

Notice of References Cited	Application/Control No. 10/559,831	Applicant(s)/Patent Under Reexamination YOO, WOONG-TUK	
	Examiner MICHAEL VANCHY JR	Art Unit 2624	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,542,624 B1	04-2003	Oda, Takahiro	382/117
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NON-PATENT DOCUMENTS

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